# Advanced Micro Devices

# **PALCE610 Family**

# **EE CMOS High Performance Programmable Array Logic**

#### DISTINCTIVE CHARACTERISTICS

- AMD's Programmable Array Logic (PAL) architecture
- Electrically-erasable CMOS technology providing half power (90 mA lcc) at high speed
  - -15 = 15-ns tpp
  - -25 = 25-ns tpp
- Sixteen macrocells with configurable I/O architecture
- Registered or combinatorial operation
- Registers programmable as D, T, J-K, or S-R

- Asynchronous clocking via product term or bank register clocking from external pins
- Register preload for testability
- Power-up reset for initialization
- Space-saving 24-pin SKINNYDIP and 28-pin PLCC packages
- Fully tested for 100% programming yield and high reliability
- Extensive third-party software and programmer support through FusionPLD partners

#### **GENERAL DESCRIPTION**

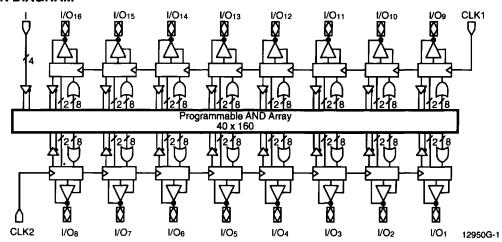
The PALCE610 is a general purpose PAL device and is functionally and fuse map equivalent to the EP610. It can accommodate logic functions with up to 20 inputs and 16 outputs. There are 16 I/O macrocells that can be individually configured to the user's specifications. The macrocells can be configured as either registered or combinatorial. The registers can be configured as D, T, J-K, or S-R flip-flops.

The PALCE610 uses the familiar sum-of-products logic with programmable-AND and fixed-OR structure. Eight product terms are brought to each macrocell to provide logic implementations.

The PALCE610 is manufactured using advanced CMOS EE technology providing low power consumption. Moreover, it is a high-speed device having a worst-case tpp of 15 ns. Space-saving 24-pin SKINNYDIP and 28-pin PLCC packages are offered.

This device can be quickly erased and reprogrammed providing for easy prototyping. Once a device is programmed the security bit can be used to provide protection from copying a proprietary design.

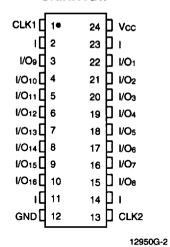
#### **BLOCK DIAGRAM**



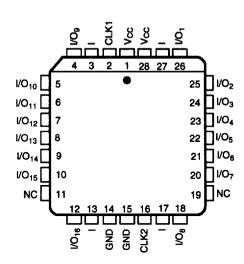
Publication# 12950 Rev. G Amendment/0 Issue Date: February 1996

# **CONNECTION DIAGRAMS Top View**





## PLCC/LCC



**Note:** Pin 1 is marked for orientation

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#### **PIN DESIGNATIONS**

CLK Clock GND Ground ı Input

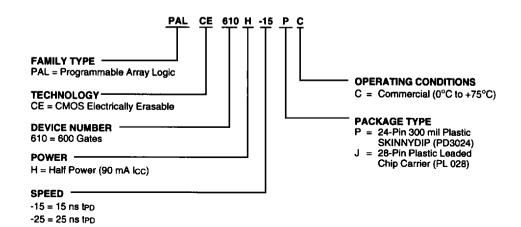
I/O Input/Output NC No Connect Vcc Supply Voltage



#### **ORDERING INFORMATION**

#### **Commercial Products**

AMD programmable logic products for commercial applications are available with several ordering options. The order number (Valid Combination) is formed by a combination of:



Valid Combinations				
PALCE610H-15				
PALCE610H-25	PC, JC			

#### **Valid Combinations**

Valid Combinations lists configurations planned to be supported in volume for this device. Consult the local AMD sales office to confirm availability of specific valid combinations, and to check on newly released combinations.

#### **FUNCTIONAL DESCRIPTION**

The PALCE610 is a general purpose programmable logic device. It has 16 independently-configurable macrocells. Each macrocell can be configured as either combinatorial or registered. The registers can be D, T, J-K, or S-R type flip-flops. The device has 4 dedicated input pins and 2 clock pins. Each clock pin controls 8 of the 16 macrocells.

The programming matrix implements a programmable AND logic array which drives a fixed OR logic array. Buffers for device inputs have complementary outputs to provide user-programmable input polarity. Unused input pins should be tied to Vcc or ground.

The array uses AMD's electrically erasable technology. An unprogrammed bit is disconnected and a programmed bit is connected. Product terms with all bits unprogrammed assume the logical-HIGH state and product terms with both the TRUE and Complement bits programmed assume the logical-LOW state.

The programmable functions in the PALCE610 are automatically configured from the user's design specifications, which can be in a number of formats. The design specification is processed by development software to verify the design and create a programming file. This file, once downloaded to the programmer, configures the design according to the user's desired function.

#### **Macrocell Configurations**

The PALCE610 macrocell can be configured as either combinatorial or registered. Both the combinatorial and registered configurations have output polarity control. The register can be configured as a D, T, J-K, or S-R type flip-flop. Figure 1 shows the possible configurations.

Each macrocell can select as its clock either the corresponding clock pin or the CLK/OE product term. If the clock pin is selected, the output enable is controlled by the CLK/OE product term. If the CLK/OE product term is selected, the output is always enabled.

#### Combinatorial I/O

All 8 product terms are available to the OR gate. The output-enable function is performed by the CLK/OE product term.

#### **Registered Configurations**

There are 4 flip-flop types available: D. T. J-K and S-R.

The registers can be configured as synchronous or asynchronous. In the synchronous configuration, the clock is controlled by the clock input pin. The output enable is controlled by the product term function. In the asynchronous configuration, the clock input is controlled by the product term. The output is always enabled

In The D and T configurations, feedback can be either from Q or the output pin. This allows D and T configurations to be either outputs or I/O. In the J-K and S-R configurations, feedback is only from Q; therefore, J-K and S-R configurations are strictly outputs.

#### D Flip-Flop

All 8 product terms are available to the OR gate. The D input polarity is controlled by an exclusive-OR gate. For the D flip-flop, the output level is the D-input level at the rising edge of the clock.

D	Qn	Qn+1
0	0	0
0	1	0
1	0	1
1	1	1

#### T Flip-Flop

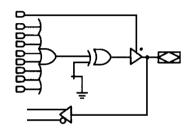
All 8 product terms are available to the OR gate. The T input polarity is controlled by an exclusive-OR gate. For the T register, the output level toggles when the T input is HIGH and remains the same when the T input is LOW.

Ţ	Qn	Qn+1
0	0	0
0	1	1
1	0	1
1	1	0

#### J-K Flip-Flop

The 8 product terms are divided between the J and K inputs. N product terms go to the J input and 8-N product terms go to the K input, where N can range from 0 to 8. Both the J and K inputs to the flip-flop have polarity control via exclusive-OR gates. The J-K flip-flop operation is shown below.

J	K	Qn	Qn+1
0	0	0	0
0	0	1	1
0	1	0	0
0	1	1	0
1	0	0	1
1	0	1	1
1	1	0	1
1	1	1	0



#### Combinatorial

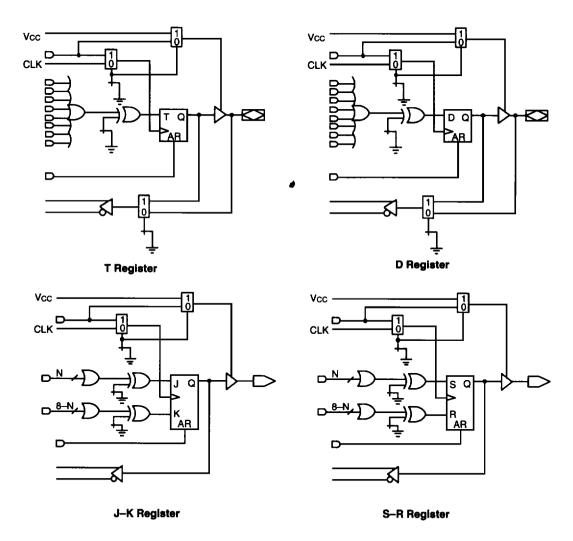


Figure 1. Macrocell Configurations

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#### S-R Flip-Flop

The 8 product terms are divided between the S and R inputs. N product terms go to the S input and 8-N product terms go to the R input, where N can range from 0 to 8. Both the S and R inputs to the flip-flop have polarity control via exclusive-OR gates. The S-R flip-flop operation is shown below.

S	R	Q <sup>n</sup>	Qn+1	
0	0	0	0	
0	0	1	1	
0	1	0	0	
0	1	1	0	
1	0	0	1	
1	0	1	1	
1	1	Not Allowed		

#### **Asynchronous Reset**

All flip-flops have an asynchronous-reset product-term input. When the product term is true, the flip-flop will reset to a logic LOW, regardless of the clock and data inputs.

#### **Power-Up Reset**

All flip-flops power up to a logic LOW for predictable system initialization. Outputs of the PALCE610 depend on whether they are selected as registered or combinatorial. If registered is selected, the output will be LOW. If combinatorial is selected, the output will be a function of the logic. The Vcc rise must be monotonic and the reset delay time is 1000 ns maximum.

#### **Register Preload**

The register on the PALCE610 can be preloaded from the output pins to facilitate functional testing of complex state machine designs. This feature allows direct loading of arbitrary states, making it unnecessary to cycle through long test vector sequences to reach a desired state. In addition, transitions from illegal states can be verified by loading illegal states and observing proper recovery.

#### Security Bit

After programming and verification, a PALCE610 design can be secured by programming the security bit. Once programmed, this bit defeats readback of the internal programmed pattern by a device programmer, securing proprietary designs from competitors. However, programming and verification are also defeated by the security bit. The bit can only be erased in conjunction with the array during the erase cycle. Preload is not affected by the security bit.

#### **Technology**

The PALCE610 is manufactured using AMD's advanced Electrically Erasable (EE) CMOS process. This technology uses an EE cell to replace the fuse link in bipolar parts, and allows AMD to offer lower-power parts of high complexity. In addition, since the EE cells can be erased and reprogrammed, these devices can be 100% factory tested before being shipped to the customer. Inputs and outputs are designed to be compatible with TTL devices. This technology provides strong input clamp diodes, output slew-rate control, and a grounded substrate for clear switching.

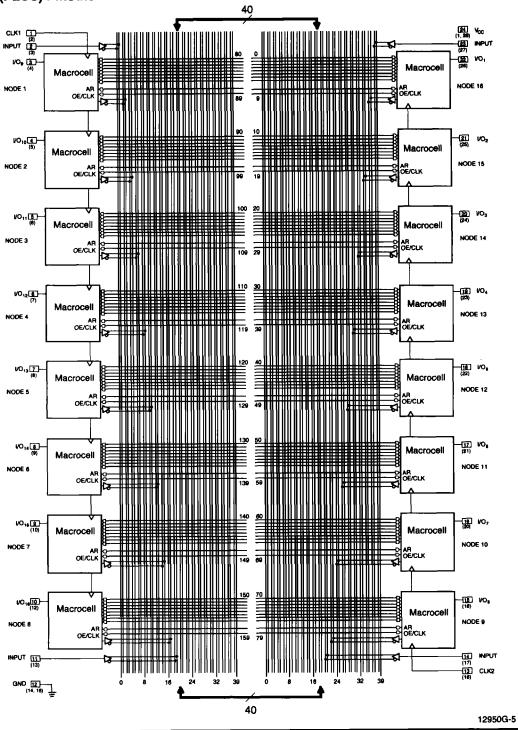
#### **Programming and Erasing**

The PALCE610 can be programmed on standard logic programmers. It also may be erased to reset a previously configured device back to its virgin state. Bulk erase is automatically performed by the programming hardware. No special erase operation is required.

#### **CMOS Compatibility**

The PALCE610 has CMOS-compatible outputs. The output voltage (Vo<sub>H</sub>) is 3.85 V at -2.0 mA.

# PALCE610 LOGIC DIAGRAM DIP (PLCC) Pinouts



#### ABSOLUTE MAXIMUM RATINGS

Storage Temperature65°C to +150°C
Ambient Temperature with Power Applied55°C to +125°C
Supply Voltage with
Respect to Ground0.5 V to +7.0 V
DC Input Voltage0.5 V to Vcc + 0.5 V
DC Output or
I/O Pin Voltage0.5 V to Vcc + 0.5 V
Static Discharge Voltage 2001 V
Latchup Current
$(T_A = 0^{\circ}C \text{ to } +75^{\circ}C)$

Stresses above those listed under Absolute Maximum Ratings may cause permanent device failure. Functionality at or above these limits is not implied. Exposure to Absolute Maximum Ratings for extended periods may affect device reliability. Programming conditions may differ.

#### **OPERATING RANGES**

#### Commercial (C) Devices

Ambient Temperature (T <sub>A</sub> ) Operating in Free Air 0°C to +75°C
Supply Voltage (Vcc) with Respect to Ground +4.75 V to +5.25

Operating ranges define those limits between which the functionality of the device is guaranteed.

# DC CHARACTERISTICS over COMMERCIAL operating ranges unless otherwise specified (Note 2)

Parameter Symbol	Parameter Description	Test Conditions		Min	Max	Unit
Vон	Output HIGH Voltage	VIN = VIH OF VIL VCC = Min	I <sub>OH</sub> = -4.0 mA I <sub>OH</sub> = -2.0 mA	2.4 3.84		V V
Vol	Output LOW Voltage	VIN = VIH OF VIL Vcc = Min	loL = 8.0 mA loL = 4.0 mA		0.5 0.45	V V
ViH	Input HIGH Voltage	Guaranteed Input Voltage for all Inp	_	2.0		٧
VIL	Input LOW Voltage	Guaranteed Input Voltage for all Inp		0.8	٧	
hн	Input HIGH Leakage Current	Vin = 5.25 V, Vcc		10	μА	
1 <sub>IL</sub>	Input LOW Leakage Current	V <sub>IN</sub> = 0 V, V <sub>CC</sub> = M		-10	μА	
lozн	Off-State Output Leakage Current HIGH	Vout = 5.25 V, Vcc = Max V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub> (Note 2)			10	μА
lozu	Off-State Output Leakage Current LOW	V <sub>OUT</sub> = 0 V, V <sub>CC</sub> = Max V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub> (Note 2)			-10	μА
Isc	Output Short-Circuit Current	Vоит = 0.5 V, Vcc	-30	-150	mA	
lcc	Supply Current	V <sub>IN</sub> = 0 V, Outputs V <sub>CC</sub> = Max		90	mA	

#### Notes:

- 1. These are absolute values with respect to device ground and all overshoots due to system and tester noise are included.
- 2. I/O pin leakage is the worst case of IIL and lozL (or IIH and lozн).
- Not more than one output should be tested at a time. Duration of the short-circuit should not exceed one second. Vour = 0.5 V
  has been chosen to avoid test problems caused by tester ground degradation.



## **CAPACITANCE (Note 1)**

Parameter Symbol	Parameter Description	Test Condition	ns	Тур	Unit
Cin	Input Capacitance	V <sub>IN</sub> = 2.0 V	Vcc = 5.0 V T <sub>A</sub> = +25°C	8	
Соит	Output Capacitance	Vout = 2.0 V	f = 1 MHz	8	pF

#### Note:

## **SWITCHING CHARACTERISTICS over COMMERCIAL operating ranges (Note 2)**

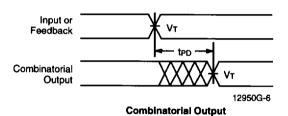
Parameter				-1	15	-2	5	
Symbol	Parameter De	escription	Min	Max	Min	Max	Unit	
teo	Input or Feedl	oack to Combinatorial Ou	itput		15		25	ns
ts	Setup Time fro	om Input or Feedback to	Clock	12		15		ns
tн	Hold Time			0		0		ns
tco	Clock to Outp	ut			8		12	ns
tw∟	Clock	LOW		6		10		ns
twн	Width	HIGH		6		10		ns
	Maximum	External Feedback	1/(ts + tco)	50		37		MHz_
fmax	Frequency (Note 3)	Internal Feedback (fcnt)	1/(ts + tcr) (Note 5)	76.1		40		MHz
		No Feedback	1/(tw+ + twL)	83.3		50		MHz
tea	Input to Output Enable Using Product Term Control				15		25	ns
ten	Input to Outpu	ıt Disable Using Product	Term Control		15		25	ns
tar	Asynchronous	Reset to Registered Ou	tput		15		25	ns
tarw	Asynchronous	Reset Width		10		15		ns
TARR	Asynchronous	Reset Recovery Time			15		25	ns
tsa	Setup Time fro	om Input or Feedback to	Clock (Note 4)	5		8		ns
tha	Hold Time (No	ote 4)		5		12		ns
tcoa	Clock to Output (Note 4)			15		27	ns	
twla	Clock	LOW (Note 4)		6		10		ns
twha	Width	HIGH (Note 4)		6		10		ns
	Maximum Frequency	Maximum External Feedback 1//tss + tsss)		50		28.6		MHz
<b>TMAXA</b>	(Notes 3	Internal Feedback (fo		61.6		29.4		MHz
	and 4)	No Feedback	1/(twla + twha)	83.3		50		MHz

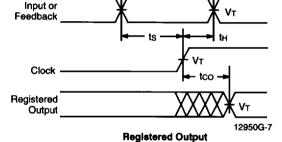
#### Notes:

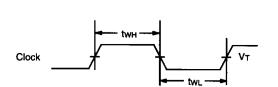
- 2. See Switching Test Circuit for test conditions.
- These parameters are not 100% tested, but are evaluated at initial characterization and at any time the design is modified where frequency may be affected.
- 4. These parameters are measured using the asynchronous product-term clock.
- t<sub>CF</sub> is a calculated value and is not guaranteed. t<sub>CF</sub> can be found using the following equation: t<sub>CF</sub> = 1/f<sub>MAX</sub> (internal feedback) – t<sub>S</sub>.

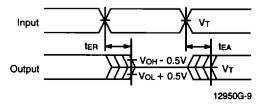
These parameters are not 100% tested, but are evaluated at initial characterization and at any time the design is modified where capacitance may be affected.

# SWITCHING WAVEFORMS





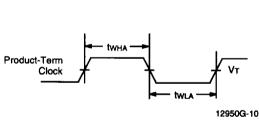


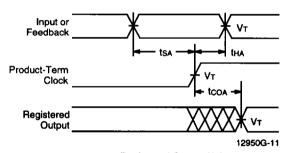


Clock Width

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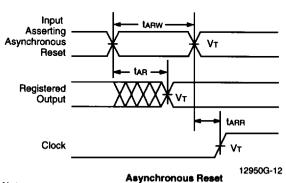
Input to Output Disable/Enable





Clock Width Using Product-Term Clock

Registered Output Using Product-Term Clock



#### Notes:

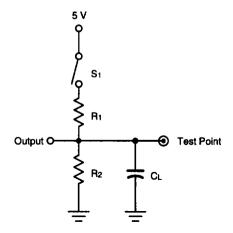
- 1. VT = 1.5 V
- 2. Input pulse amplitude 0 V to 3.0 V
- 3. Input rise and fall times 2 ns-5 ns typical.

# **KEY TO SWITCHING WAVEFORMS**

WAVEFORM	INPUTS	OUTPUTS
	Must be Steady	Will be Steady
	May Change from H to L	Will be Changing from H to L
	May Change from L to H	Will be Changing from L to H
	Don't Care, Any Change Permitted	Changing, State Unknown
<b>&gt;&gt;</b>	Does Not Apply	Center Line is High- Impedance "Off" State

KS000010-PAL

# **SWITCHING TEST CIRCUIT**



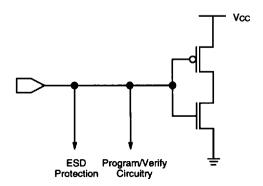
12950G-13

			Commercial		Measured
Specification	S <sub>1</sub>	CL	R <sub>1</sub>	R <sub>2</sub>	Output Value
tpp, tco	Closed				1.5 V
tEA	Z → H: Open Z → L: Closed	35 pF	855 Ω	340 Ω	1.5 V
ten	H → Z: Open L → Z: Closed	5 pF			H → Z: VoH − 0.5 V L → Z: VoL + 0.5 V

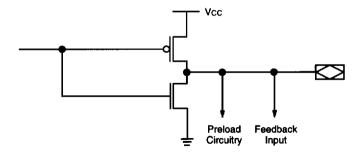
#### **ENDURANCE**

Symbol	Parameter Description	Test Conditions	Min	Unit
ton	Pattern Data Retention Time	Max Storage Temperature	10	Years
		Max Operating Temperature	20	Years
N	Reprogramming Cycles	Normal Programming Conditions	100	Cycles

## INPUT/OUTPUT EQUIVALENT SCHEMATICS



Typical Input



Typical Output

12950G-14



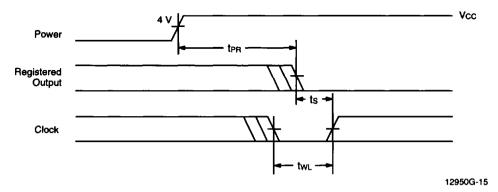
#### **Power-Up Reset**

The power-up reset feature ensures that all flip-flops will be reset to LOW after the device has been powered up. This feature is valuable in simplifying state machine initialization. A timing diagram and parameter table are shown below. Due to the synchronous operation of the power-up reset and wide range of ways Vcc can rise to

its steady state, two conditions are required to insure a valid power-up reset. These conditions are:

- The V<sub>CC</sub> rise must be monotonic.
- Following reset, the clock input must not be driven from LOW to HIGH until all applicable input and feedback setup times are met.

Parameter Symbol	Parameter Description	Max	Unit	
t <sub>PR</sub>	Power-up Reset Time	1000	ns	
ts	Input or Feedback Setup Time	See S	See Switching Characteristics	
twL	Clock Width LOW	Chara		



**Power-Up Reset Waveform** 



#### TYPICAL THERMAL CHARACTERISTICS

Measured at 25°C ambient. These parameters are not tested.

Parameter			Тур		
Symbol	Parameter Description		SKINNYDIP	PLCC	Unit
θjc	Thermal impedance, junction to case		21	20	°C/W
<del>0</del> ja	Thermal impedance, junction to ambient		72	57	•c⁄w
0jma	Thermal impedance, junction to ambient with air flow	200 lfpm air	64	47	°C/W
		400 lfpm air	60	44	•c⁄w
		600 lfpm air	55	40	°C/W
		800 lfpm air	49	36	°C/W

#### Plastic 9jc Considerations

The data listed for plastic θjc are for reference only and are not recommended for use in calculating junction temperatures. The heat-flow paths in plastic-encapsulated devices are complex, making the θjc measurement relative to a specific location on the package surface. Tests indicate this measurement reference point is directly below the die-attach area on the bottom center of the package. Furthermore, θjc tests on packages are performed in a constant-temperature bath, keeping the package surface at a constant temperature. Therefore, the measurements can only be used in a similar environment.